

STG4158

Low voltage 0.6 Ω typ single SPDT switch with break-before-make feature and 15 kV ESD protection

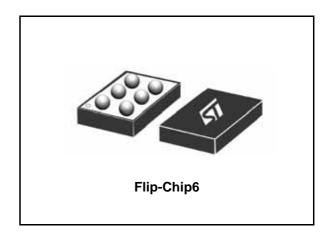
Features

- Power-off and over-voltage protection
- Wide operating voltage range: V_{CC} (opr) = 1.65 to 4.5 V
- Low ON resistance V_{IN} = 0 V:
 - R_{ON} = 0.85 Ω (max) at V_{CC} = 4.5 V
- Latch-up performance exceeds 300 mA JESD 17
- ESD performance tested on (D pin)
 - 8 kV IEC-61000-4-2 ESD, contact discharge
 - 15 kV IEC-61000-4-2 ESD, air discharge
- ESD performance test on all other pins
 - 3 kV Human-Body-Model
 - 200 V machine model (IEC61340-3-2 level M2)
 - 1000 V charge-device model (JESD22 C101)

Description

The STG4158 is a high-speed CMOS low voltage single analog SPDT (single pole dual throw) switch or 2:1 multiplexer/demultiplexer switch fabricated in silicon gate C²MOS technology. Designed to operate from 1.65 to 4.5 V, this device is ideal for portable applications.

It offers low ON resistance (0.6 Ω) at V_{CC} = 4.5 V (typical T_A = 25 °C). The SEL input threshold is compatible to 1.8 V, and provides control to the switches.



The switch S1 is ON (connected to common port D) when the SEL input is held high and OFF (high impedance state exists between the two ports) when SEL is held low. The switch S2 is ON (connected to common port D) when the SEL input is held low and OFF (high impedance state exists between the two ports) when SEL is held high.

The SEL input has an integrated weak pull-down resistor to prevent SEL signal from floating. For low power consumption, the SEL input must be grounded.

Power-off and over-voltage protection

The STG4158 features power-off and overvoltage protection, enabling the device to be isolated during voltage fault events.

Table 1. Device summary

Order code	Package	Packing	
STG4158BJR	Flip-Chip6	Tape and reel	

November 2007 Rev 1 1/21

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STG4158 Logic diagram

1 Logic diagram

Figure 1. Functional diagram

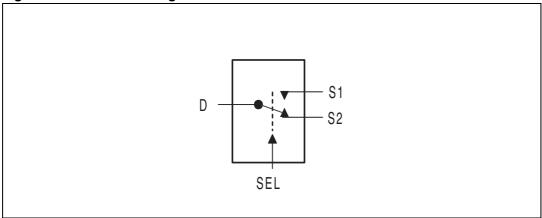


Figure 2. Input equivalent circuit

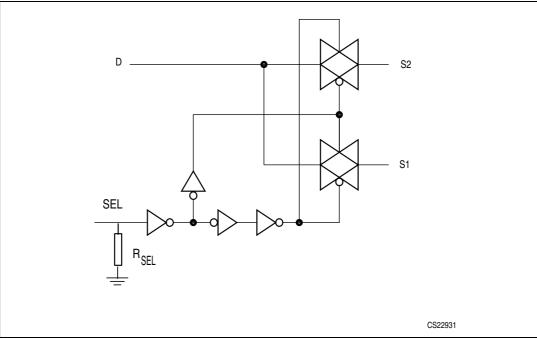


Table 2. Truth table

SEL	Switch S1	Switch S2
Н	ON	OFF ⁽¹⁾
L	OFF ⁽¹⁾	ON

1. High impedance

Logic diagram STG4158

Figure 3. Pin connection (bump side view)

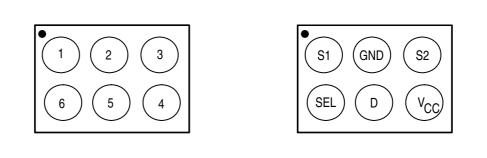


Table 3. Pin description

Flip-Chip	Symbol	Name and function
1, 3	S1, S2	Independent channels
5	D	Common channel
6	SEL	Control
4	V _{CC}	Positive supply voltage
2	GND	Ground (0V)

STG4158 Maximum rating

2 Maximum rating

Stressing the device above the rating listed in the "absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{CC}	Supply voltage	-0.5 to 5.5	V
V _I	DC input voltage	-0.5 to V _{CC} + 0.5	V
V _{IC}	DC control input voltage	-0.5 to 5.5	V
Vo	DC output voltage	-0.5 to V _{CC} + 0.5	V
I _{IKC}	DC input diode current on control pin (V _{SEL} < 0 V)	- 50	mA
I _{IK}	DC input diode current (V _{SEL} < 0V)	± 50	mA
I _{OK}	DC output diode current	± 20	mA
I _O	DC output current	± 300	mA
I _{OP}	DC output current peak (pulse at 1ms, 10% duty cycle)	± 500	mA
I _{CC} or I _{GND}	DC V _{CC} or ground current	± 100	mA
P _D	Power dissipation at T _A = 70°C ⁽¹⁾	500	mW
T _{stg}	Storage temperature	-65 to 150	°C
T _L	Lead temperature (10 sec)	260	°C

^{1.} Derate above 70°C by 18.5 mW/C

Table 5. Recommended operating conditions

Symbol	Parameter	Value	Unit	
V _{CC}	Supply voltage		1.65 to 4.5	V
V _I	Input voltage		0 to V _{CC}	V
V _{IC}	Control input voltage	Control input voltage		
Vo	Output voltage		0 to V _{CC}	V
T _{op}	Operating temperature		-40 to 85	°C
dt/dv	input nee and rain time control	V _{CC} = 1.65 to 2.7 V	0 to 20	ns/V
ui/uv		V _{CC} = 3.0 to 4.5V	0 to 10	ns/v

5//

Electrical characteristics

3 Electrical characteristics

Table 6. DC specifications

						Value			
Symbol	Parameter	V _{CC} (V)	Test condition	T	_A = 25 °	С	-40 to 85 °C		Unit
		(*)		Min	Тур	Max	Min	Max	
		1.65 – 1.95		0.9			0.9		
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	High level	2.25 – 2.7		0.9			0.9		V
V _{IH}	input voltage	3.0 – 4.3		1.0			1.0		ľ
		4.5		1.1			1.1		
		1.65 – 1.95				0.6		0.6	
\/	Low level	2.25 – 2.7				0.6		0.6	V
V _{IL}	input voltage	3.0 – 4.3				0.7		0.7	ľ
		4.5				0.7		0.7	
		1.65 – 2.20	$V_S = 0 \text{ V to } V_{CC}$ $I_S = 100 \text{ mA}$		2.0			3.0	
R _{ON}	ON resistance	2.25 – 3.6			0.9			1.3	Ω
		3.7 – 4.5			0.6			0.85	
	ON	1.65 – 2.20	$V_S = 0 \text{ V to } V_{CC}$ $I_S = 100 \text{ mA}$		40			400	
ΔR _{ON}	resistance match	2.25 – 3.6			10			100	mΩ
014	between channels (1)	3.7 – 4.5			10			100	
	ON	1.65 – 2.20			1.2				
R _{FLAT}	resistance	2.25 – 3.6	$V_S = 0 \text{ V to } V_{CC}$ $I_S = 100 \text{ mA}$		0.3			0.6	Ω
	flatness (2)	3.7 – 4.5	15 - 100 1111		0.2			0.4	
R _{SEL}	SEL pull- down resistance	1.65 – 4.5			5000				kΩ
I _{OFF}	Sn OFF state leakage current	1.65 – 4.5	$\begin{aligned} &V_S = 0, \\ &V_D = V_{CC} \\ &V_S = V_{CC}, \\ &V_D = 0 \end{aligned}$	-30		30	-300	300	nA
I _{ON}	Sn ON state leakage current	1.65 – 4.5	$V_S = 0$ to V_{CC} $V_D = open$	-20		20	-200	200	nA

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Table 6. DC specifications (continued)

	-	,		Value					
Symbol Parameter	Parameter	V _{CC} (V)	Test condition	T _A = 25 °C			-40 to 85 °C		Unit
		,		Min	Тур	Max	Min	Max	
	D ON state	1.65 – 4.5	$V_S = \text{open}$ $V_D = 0 \text{ to } V_{CC}$	-30		30	-300	300	nA
I _D	leakage	Floating	$V_D = 0 - 4.5$		10			25	μΑ
	current	0 – 0.5	V _D = 0 - 4.5		10			25	μА
		V _{CC} > 0.5	$V_{D} \ge V_{CC} + 0.4$		10			25	μА
	0.011.11	1.65 – 4.5	$V_S = 0 \text{ to } V_{CC}$ $V_D = \text{open}$	-30		30	-300	300	nA
Is	S ON state leakage	Floating	V _S = 0 - 4.5		5			15	μΑ
	current	0 – 0.5	V _S = 0 - 4.5		5			15	μА
		Vcc > 0.5	$V_S \ge V_{CC} + 0.4$		5			15	μА
	Quiescent	2.5	V _{SEL} = V _{CC}		5.6			10	μΑ
I _{CC}	supply	4.5	VSEL - VCC		9			20	μΑ
	current	1.65 – 4.5	V _{SEL} = GND		0.05			0.1	μΑ
		1.65 – 4.5	V _{SEL} = GND		0.1			1.0	μΑ
I _{SEL}	SEL leakage current	2.5	V _{SEL} = V _{CC}		0.5			1.0	μΑ
		4.5	V _{SEL} = V _{CC}		1.0			2.0	μА
Icclv	Quiescent supply current low voltage driving	4.5	V _{SEL} = 1.45 V		8			20	μА

Table 7. AC electrical characteristics ($C_L = 35 \text{ pF}, R_L = 50 \Omega t_f = t_f \le 5 \text{ ns}$)

						Value			
Symbol	Parameter	V _{CC} (V)	Test condition	Т	A = 25 °	С	-40 to	85 °C	Unit
		(*)		Min	Тур	Max	Min	Max	
		1.65 – 1.95			0.13				
t _{PLH} ,	Propagation	2.25 – 2.7			0.15				ns
t _{PHL}	delay	3.0 – 3.6			0.16				
		3.7 – 4.5			0.16				
		1.65 – 1.95	$V_S = V_{CC}$		112			160	
t _{ON}	Turn on time	2.25 – 2.7	$R_L = 50 \Omega$		64			86	ns
			C _L = 30 pF		43			58	
		3.7 – 4.5			28			38	
		1.65 – 1.95	$V_S = V_{CC}$ $R_L = 50 \Omega$ $C_L = 30 \text{ pF}$		14			20	
t _{OFF}	Turn off time	2.25 – 2.7			13			18	ns
					13			18	
		3.7 – 4.5			13			18	
	Break-before-	1.65 – 1.95	C _L = 35 pF	10	86				
t _D	make time	2.25 – 2.7	$R_L = 50 \Omega$	10	56				ns
	delay		$V_S = V_{CC}/2$	5	31				1
		3.7 – 4.5		5	25				
		1.65 – 1.95			70				
Q	Charge injection	2.25 – 2.7	$C_L = 1 \text{ nF}$		140				pC
	injection	3.0 – 3.6	$V_{GEN} = 0 V$		190				
		3.74.5			230				

Table 8. Analog switch characteristics ($C_L = 5 \text{ pF}, R_L = 50 \Omega, T_A = 25 ^{\circ}C$)

						Value					
Symbol	Parameter	V _{CC} (V)	Test condition	T,	_A = 25 °	С	-40 to	85 °C	Unit		
		,		Min	Тур	Max	Min	Max			
			$V_S = 1 V_{RMS}$ f = 100 kHz		-76						
OIRR	Off isolation (1)	1.65 – 4.5	$V_S = 1 V_{RMS}$ f = 1 MHz		-55				dB		
			$V_S = 1 V_{RMS}$ f = 5 MHz		-40						
			$V_S = 1 V_{RMS}$ f = 100 kHz		-81						
Xtalk	Crosstalk	1.65 – 4.5	$V_S = 1 V_{RMS}$ f = 1 MHz		-61				dB		
					$V_S = 1 V_{RMS}$ f = 5 MHz		-48				
THD	Total harmonic distortion	2.3 – 4.5	$R_{L} = 600 \Omega$ $C_{L} = 50 \text{ pF}$ $V_{S} = V_{CC} V_{PP}$ $f = 600 \text{ Hz to}$ 20 kHz		0.015				%		
BW	-3dB bandwidth (switch ON)	1.65 – 4.5	R _L = 50 Ω		40				MHz		
C _{SEL}	Control pin input capacitance	1.8 – 4.5	$V_L = V_{CC}$		30						
C _{Sn}	Sn port capacitance	1.8 – 4.5	V _L = V _{CC}		80				рF		
C _D	D port capacitance when switch is enabled	1.8 – 4.5	$V_L = V_{CC}$		190						

^{1.} OFF-isolation = 20 \log_{10} (VD/VS), V_D = output, V_S = input to off switch

4 Application information

Power-off and over-voltage protection

The STG4158 has two operation modes:

- Normal operation mode
- 2. Isolation mode

In the normal operation mode, the switch functions as a normal SPDT, with the SEL pin that selects the switch to be either ON or OFF. Either S1 or S2 is connected to common channel D.

In the isolation mode, all the switches are OFF. S1 or S2 are isolated from common channel D. The S1, S2, D ports have a 1 $M\Omega$ impedence to ground.

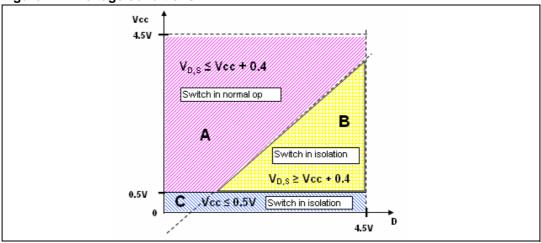
The operation modes are made possible by special detection circuitry that detects the voltage level at D, S1 and S2 supplies. Depending on these voltage levels, the device goes into isolation mode or normal operation mode accordingly.

The isolation mode is a feature of the device that is useful during fault conditions that occur in the application environment.

Table 9. Voltage conditions

V _{CC}	V _{D,S} (voltage at common port D, S1 or S2)	Voltage condition	Mode
Floating	0 – 4.5 V	All switches OFF S1,S2 and D are isolated from each other	Isolation
0 – 0.5 V	0 – 4.5 V	All switches OFF S1, S2, D are isolated from each other	Isolation
V _{CC} > 0.5	$V_{D,S} > V_{CC} + 0.4$	All switches OFF S1,S2 and D are isolated from each other	Isolation
1.65 – 4.5 V	0 - V _{CC}	Either S1 or S2 is connected to D, depending on SEL input	Normal

Figure 4. Voltage conditions



The SEL input has an integrated weak pull-down resistor R_{SEL} to prevent SEL signal from floating. For lower power consumption, the SEL input must be grounded.

Test circuits STG4158

5 Test circuits

Figure 5. ON resistance

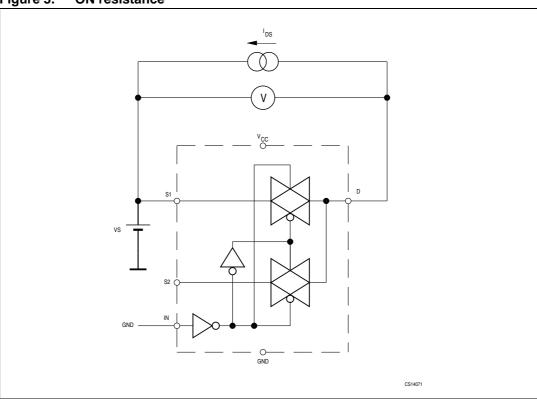
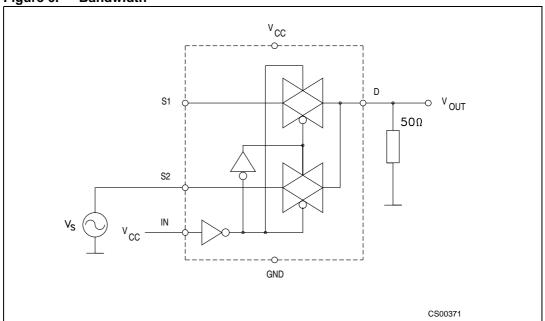


Figure 6. Bandwidth



STG4158 Test circuits

Figure 7. OFF leakage

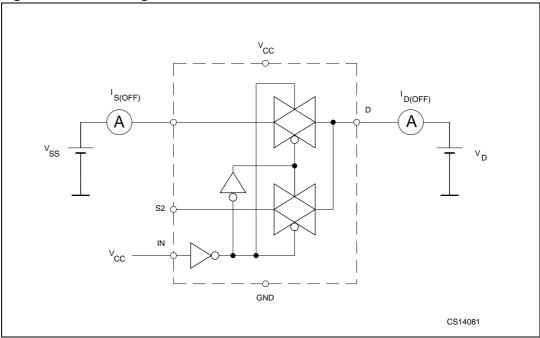
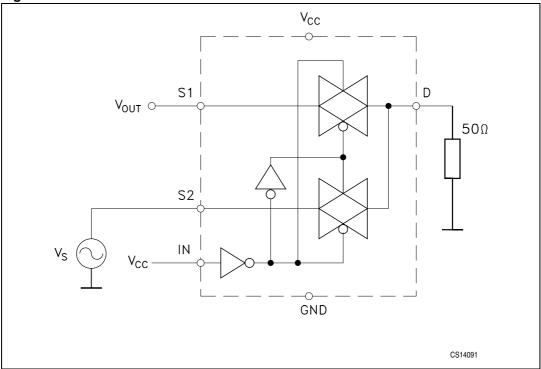


Figure 8. Channel-to-channel crosstalk



Test circuits STG4158

Figure 9. OFF isolation

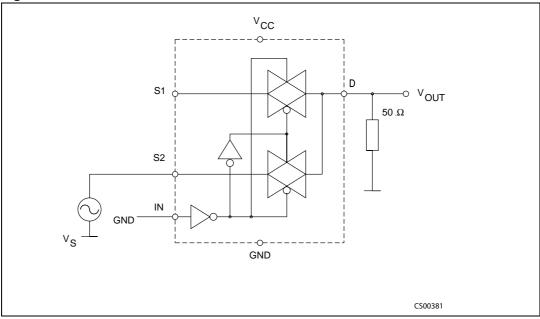
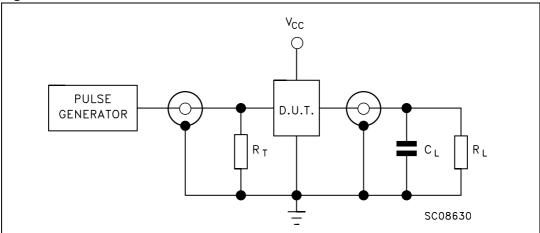


Figure 10. Test circuit



- 1. $C_L = 5/35 \text{ pF}$ or equivalent: (includes jig capacitance)
- 2. $R_L = 50 \Omega$ or equivalent
- 3. $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)

STG4158 Test circuits

Figure 11. Break-before-make time delay

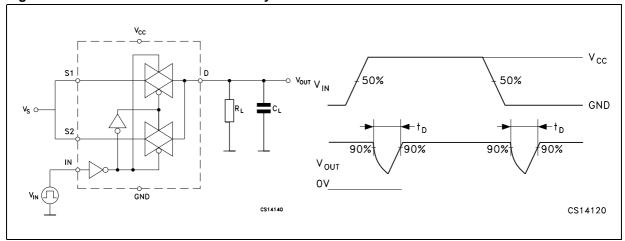


Figure 12. Switching time and charge injection

 $(V_{GEN} = 0 \text{ V}, R_{GEN} = 0 \Omega, R_L = 1 \text{ M}\Omega, C_L = 100 \text{ pF})$

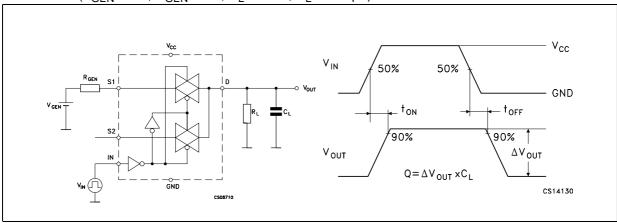
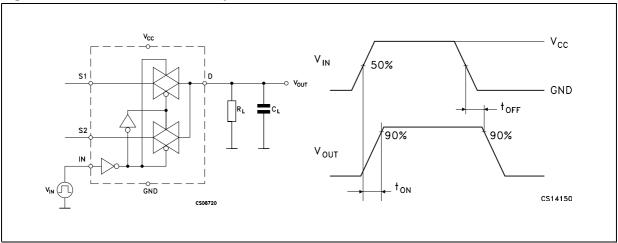


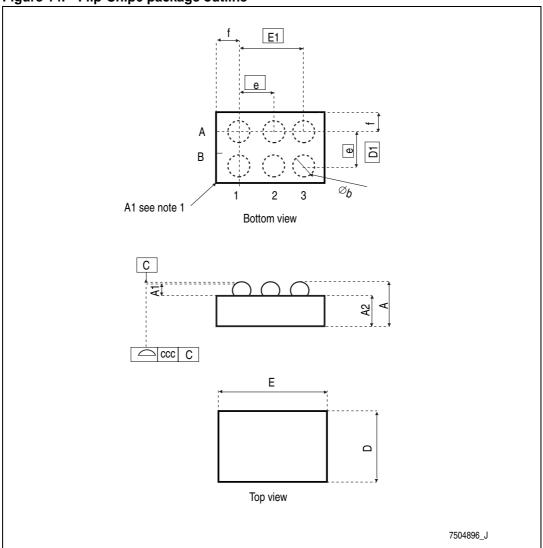
Figure 13. Turn ON, turn OFF delay time



6 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK[®] packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

Figure 14. Flip-Chip6 package outline



- The terminal pin 1 on the bumps side is identified by a distinguishing feature (for instance by a circular "clear area" - typically 0.1mm diameter). The terminal pin 1 on the backside of the product is identified by a distinguishing feature (for instance by a circular "dot" - typically 0.5 mm diameter).
- 2. Drawing not to scale.

Table 10. Flip-Chip6 mechanical data

Symbol	millimeters						
Symbol	Min	Тур	Max				
А	0.545	0.6	0.655				
A1	0.17	0.2	0.23				
A2	0.375	0.4	0.425				
b	0.23	0.255	0.28				
D	0.813	0.828	0.843				
D1	0.39	0.4	0.41				
E	1.213	1.228	1.243				
E1	0.79	0.8	0.81				
е	0.36	0.4	0.44				
f	0.204	0.214	0.224				
ccc		0.05					

Figure 15. Footprint recommendation

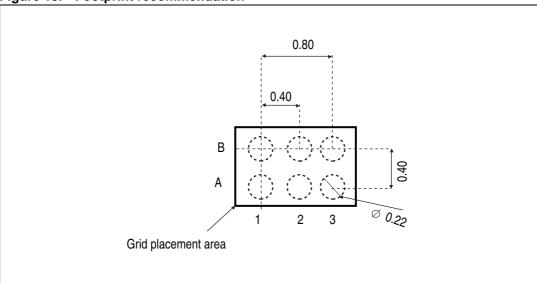


Figure 16. Flip-Chip6 marking

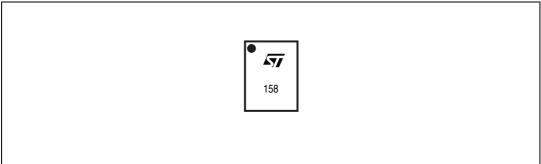


Figure 17. Flip-Chip6 tape specification

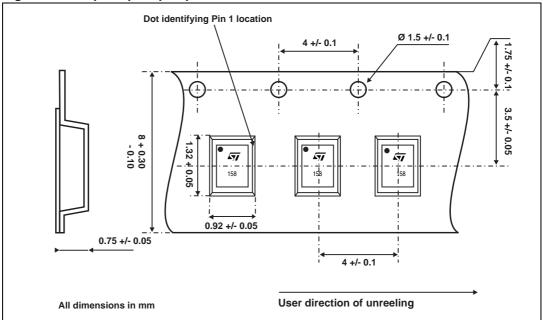


Figure 18. Flip-Chip6 reel information)

Revision history STG4158

7 Revision history

Table 11. Document revision history

Date	Revision	Changes
12-Nov-2007	1	Initial release.

STG4158

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